

Test Probe GKS-075 306 120 A 2000

Item GKS-075-0029

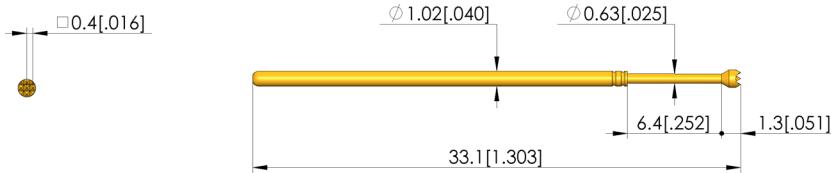


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- Well-established test probes for contacting PCBs
- For optimal contact to the test points (e.g. pads, vias, and pins), various tip styles with various diameters and finishes are available.
- Various spring forces available as well as versions with stainless steel springs suitable for high temperatures
- Used for setting the optimum stroke conditions in the test fixture, various installation heights can be achieved by combining test probes and receptacles

INGUN SELECTION



General data

Product group: ICT / FCT (in-circuit test and function test)
Sub-product group: Standard stroke test probe
Series: GKS-075
Grid: 1.91 mm [75.1 mil]
Contacting from: Post
Magnetic: Yes
Installation type: Plug-in
Quick-exchange system: Yes
Adjustable installation height: No
Non-rotating: No
Compatible receptacle(s): KS-075
Min. temperature: -40 °C [-40 °F]
Max. temperature: 80 °C [176 °F]
RoHS-compliant: Yes

ICT / FCT (in-circuit test and function test)
Standard stroke test probe
GKS-075

1.91 mm [75.1 mil]

Post

Yes

Plug-in

Yes

Yes

No

No

KS-075

-40 °C [-40 °F]

80 °C [176 °F]

Yes

Tip style data

Tip style: 06 serrated
Tip diameter: 1.2 mm [.047 in]
Tip style surface: A gold
Tip style material: 3 CuBe

Electrical data

Current load capacity / rated current: 4 A
Typical resistance (R_i): 20 mOhm

Mechanical data

Total length: 33.1 mm [1.3 in]
Barrel diameter: 1.02 mm [.04 in]
Maximum stroke: 6.35 mm [.25 in]
Spring pre-load: 0.72 N [2.58 ozf]
Collar height: 00
Spring force at working stroke: 2 N [7.19 ozf]
Recommended working stroke: 4.3 mm [.169 in]

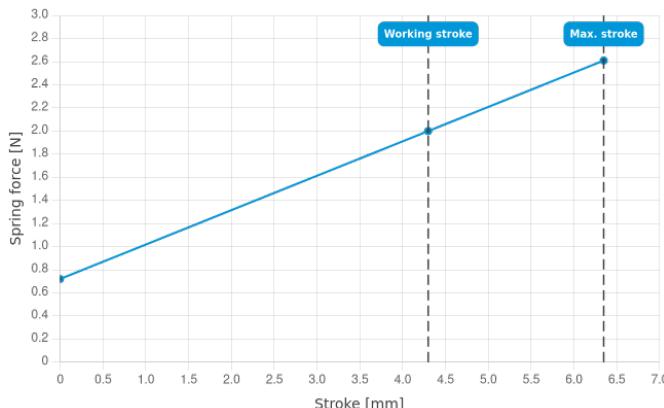
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Prices and delivery times on request.
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